

Issue Classification 	Application No. 10/633,230	Applicant(s) MIWA, TADASHI
Examiner Andy Huynh	Art Unit 2818	

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
257		316		257	202	208	239	261	298	315	
INTERNATIONAL CLASSIFICATION											
H	0	1	L	29/788							
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Andy Huynh 12/04 (Assistant Examiner) (Date)				David Neims Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date)					Total Claims Allowed: 11		
G. Stanley 12-14-04 (Legal Instruments Examiner) (Date)									O.G. Print Claim(s)	O.G. Print Fig.	
									1	4	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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